

Search Notes

Application/Control No.

10/017,471

Examiner

Nashaat T. Nashed, Ph. D.

Applicant(s)/Patent under
Reexamination

TAKANO ET AL.

Art Unit

1656

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
WEST SEARCH, enclosed.	8/11/2005	NASH
SEQ SEARCH of SEQ ID NO's: 1, 2, and 17	7/22/2005	NASH